

Notice of References Cited	Application/Control No. 10/786,001	Applicant(s)/Patent Under Reexamination LEE ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,404,357 A	04-1995	Ito et al.	714/719
*	B	US-6,493,302 B2	12-2002	Takahashi, Hideki	369/53.15
*	C	US-6,552,982 B1	04-2003	Fukushima et al.	369/47.52
*	D	US-6,564,345 B1	05-2003	Kim et al.	714/723
*	E	US-2003/0156471 A1	08-2003	Ueda et al.	365/200
*	F	US-2003/0179669 A1	09-2003	Takahashi et al.	369/47.14
*	G	US-2004/0090888 A1	05-2004	Park et al.	369/047.14
*	H	US-2004/0145980 A1	07-2004	Park et al.	369/047.14
*	I	US-2004/0174793 A1	09-2004	Park et al.	369/059.25
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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